

TOSHIBA PHOTO IC SILICON EPITAXIAL PLANAR

TPS807

PHOTO IC FOR PHOTO INTERRUPTER

PHOTOELECTRIC COUNTER

POSITION AND ROTATIONAL SPEED SENSOR

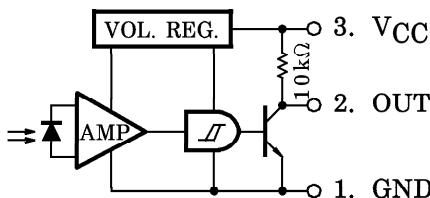
- TPS807 is a photo IC integrating photo diode, amplifier circuit and waveform shaping circuit in 1 chip.
- Visible light cut resin is used. : $\lambda_P = 900\text{nm}$ (TYP.)
- The same external shape as the infrared LED TLN107A, and is best suited for combination with TLN107A as a photo interrupter.
- High speed response : $t_{PLH} = 2\mu\text{s}$, $t_{PHL} = 6\mu\text{s}$ (TYP.)
- When light is received, output becomes high level.

MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V _{CC}	17	V
High Level Output Voltage	V _{OH}	V _{CC} (Note)	V
Low Level Output Voltage	I _{OL}	50	mA
Low Level Output Current Derating ($T_a > 25^\circ\text{C}$)	$\Delta I_{OL} / ^\circ\text{C}$	-0.67	mA / $^\circ\text{C}$
Power Dissipation	P _O	250	mW
Power Dissipation Derating ($T_a > 25^\circ\text{C}$)	$\Delta P_O / ^\circ\text{C}$	-3.33	mW / $^\circ\text{C}$
Operating Temperature Range	T _{opr}	-25~85	$^\circ\text{C}$
Storage Temperature Range	T _{stg}	-40~100	$^\circ\text{C}$
Soldering Temperature (5s)	T _{sol}	260	$^\circ\text{C}$

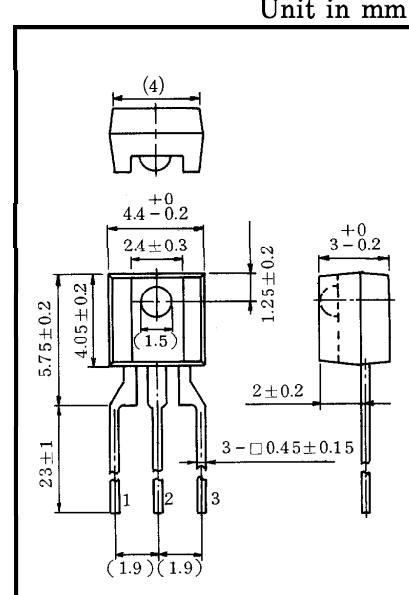
Note : V_{OH} keeps under V_{CC} Voltage.

PIN CONNECTION



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() : REFERENCE VALUE

JEDEC —

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TOSHIBA 0-4C1

Weight : 0.19g (TYP.)

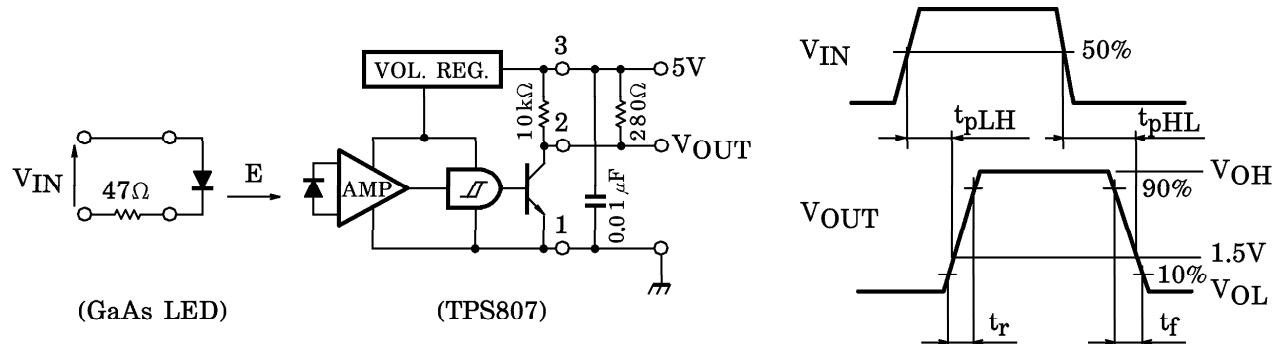
OPTO-ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

$T_a = 0 \sim 70^\circ\text{C}$, Characteristics with no entry of $T_a = 25^\circ\text{C}$ in the test conditions. Typical values are all at 25°C .)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V _{CC}		—	4.5	—	17	V
Output Voltage	Low Level	V _{OL}	I _{OL} =16mA, V _{CC} =5V, E=0	—	0.07	0.4	V
	High Level	V _{OH}	V _{CC} =5V, E=2mW/cm ²	4.5	5	—	V
Supply Current	Low Level	I _{CCL}	V _{CC} =5V, E=0	—	3.0	5.5	mA
	High Level	I _{CCH}	V _{CC} =5V, E=2mW/cm ²	—	1.2	3	mA
“L”→“H” Threshold Radiant Incidence (Note 1)	E _{LH}	V _{CC} =5V, T _a =25°C	—	0.1	0.3	—	mW/cm ²
		V _{CC} =5V	—	—	0.6	—	mW/cm ²
Histerisis Ratio	E _{HL} /E _{LH}	T _a =25°C, V _{CC} =5V	—	0.65	—	—	—
Peak Sensitivity Wavelength	λ _P	—	—	900	—	—	nm
Switching Time	Propagation “L”→“H”	t _{pLH}	Ta=25°C, V _{CC} =5V E=2mW/cm ² R _L =280Ω (Note 2)	—	2	—	μs
	Delay Time “H”→“L”	t _{pHL}		—	6	—	
	Rise Time	t _r		—	0.1	—	
	Fall Time	t _f		—	0.03	—	

Note 1 : Color temperature=2870°K, Standard Tungsten Lamp.

Note 2 : Switching time test circuit.



RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V _{CC}	4.5	5	16	V
High Level Output Voltage	V _{OH}	4.5	—	V _{CC}	V
Radiant Incidence	E	0.8	—	—	mW / cm ²
Operating Temperature	T _{opr}	0	—	70	°C

PRECAUTION

Please be careful of the followings.

1. If the lead is formed, the lead should be formed at a distance of 2mm from the body of the device.
Soldering shall be performed after lead forming.
(Soldering portion of lead : above 2mm from the body of the device.)
2. Supply the by-pass condenser up to 0.01μF between V_{CC} and GND near device to stabilize the power supply line.
3. During 100μs after turning on V_{CC}, output voltage changes for stabilizing the inner circuit.

